



**Silicon NPN Bipolar Transistor for Low-frequency Amplification**  
**3DD5011A9**

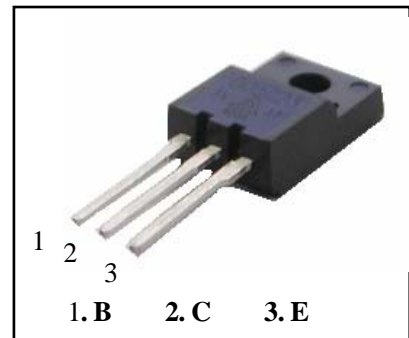
**1 Description:**

3DD5011A9, silicon NPN low frequency power transistor, is used to colour TV switching regulator.  
 Package: TO-220F.

Typical Data		
V <sub>CEO</sub>	600	V
I <sub>C</sub>	10	A
P <sub>tot</sub> (T <sub>C</sub> =25°C)	40	W

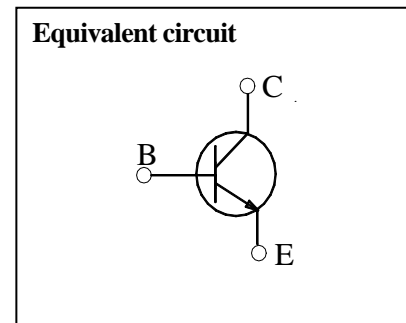
**2 Characteristics:**

- Low switching power dissipation
- Low reversing leaking current
- Good high-temperature characteristic
- Good current characteristic
- High reliability



**3 Application:**

The device is mainly used in 14 and 21 inch colour TV switching regulator.



**The name and content of poisonous and harmful material in products**

Part's Name	hazardous substance					
	Pb	Hg	Cd	Cr(VI)	PBB	PBDE
CONTENT	≤0.1%	≤0.1%	≤0.01%	≤0.1%	≤0.1%	≤0.1%
Lead Frame	○	○	○	○	○	○
Molding Compound	○	○	○	○	○	○
Chip	○	○	○	○	○	○
Wire Bonding	○	○	○	○	○	○
Solder	×	○	○	○	○	○
Note	○: means the hazardous material is under the criterion of SJ/T11363-2006. ×: means the hazardous material exceeds the criterion of SJ/T11363-2006. The plumbum element of solder exist in products presently, but within the allowed range of Eurogroup's ROHS.					

#### 4 Electrical Characteristics

##### Maximum Ratings

Except for Other Prescription,  $T_a=25^\circ\text{C}$

Parameter Note		Symbol	Rating	Unit
Collector-Base Breakdown Voltage		$V_{CBO}$	900	V
Collector-Emitter Breakdown Voltage		$V_{CEO}$	600	V
Emitter-Base Breakdown Voltage		$V_{EBO}$	9	V
Collector Current		$I_C$	10	A
Power Dissipation	$T_a=25^\circ\text{C}$	$P_{tot}$	2	W
	$T_c=25^\circ\text{C}$		40	
Junction Temperature		$T_j$	150	$^\circ\text{C}$
Storage Temperature		$T_{stg}$	-55~150	$^\circ\text{C}$

##### Electrical characteristics

Except for Other Prescription,  $T_a=25^\circ\text{C}$

Parameter Note	Symbol	Test Conditions	Criterion			Unit
			Min	Typ	Max	
Collector-Base Cutoff Current	$I_{CBO}$	$V_{CB}=800\text{V}, I_E=0$			10	$\mu\text{A}$
Collector- Emitter Cutoff Current	$I_{CEO}$	$V_{CE}=600\text{V}, I_B=0$			100	$\mu\text{A}$
Emitter-Base Cutoff Current	$I_{EBO}$	$V_{EB}=9\text{V}, I_C=0$			10	$\mu\text{A}$
Collector-Base Breakdown Voltage	$V_{CBO}$	$I_{CB}=1\text{mA}, I_E=0$	900			V
Collector-Emitter Breakdown Voltage	$V_{CEO}$	$I_{CE}=5\text{mA}, I_B=0$	600			V
Emitter-Base Breakdown Voltage	$V_{EBO}$	$I_{EB}=1\text{mA}, I_C=0$	9			V
DC Current Gain	$h_{FE}^a$	$V_{CE}=5\text{V}, I_C=1\text{A}$	15		30	
Ratio Between $h_{FE1}$ of Low Current and $h_{FE2}$ of High Current	$h_{FE1}$	$h_{FE1}: V_{CE}=5\text{V}, I_C=5\text{A}$	6			
	$h_{FE2}$	$h_{FE2}: V_{CE}=5\text{V}, I_C=1\text{mA}$	10			
Collector-Emitter Saturation Voltage	$V_{CE\text{ sat}}^a$	$I_C=4\text{A}, I_B=0.8\text{A}$		0.25	1	V
Base-Emitter Saturation Voltage	$V_{BE\text{ sat}}^a$	$I_C=4\text{A}, I_B=0.8\text{A}$		0.88	1.5	V
Storage Time	$t_s$	UI9600, $I_C=0.5\text{A}$		7.5	10	$\mu\text{s}$
Fall Time	$t_f$			0.6	1	$\mu\text{s}$
Transition Frequency	$f_T$	$V_{CE}=10\text{V}, I_C=0.1\text{A}$ $f=0.3\text{MHz}$	4	12		MHz

a: Impulse  $t_p \leq 300 \mu\text{s}, \delta \leq 2\%$

### 5 Typical Characteristics

Figure 1 Safe Operating Area

Figure2 Power Derating( $P_{tot}-T$ )

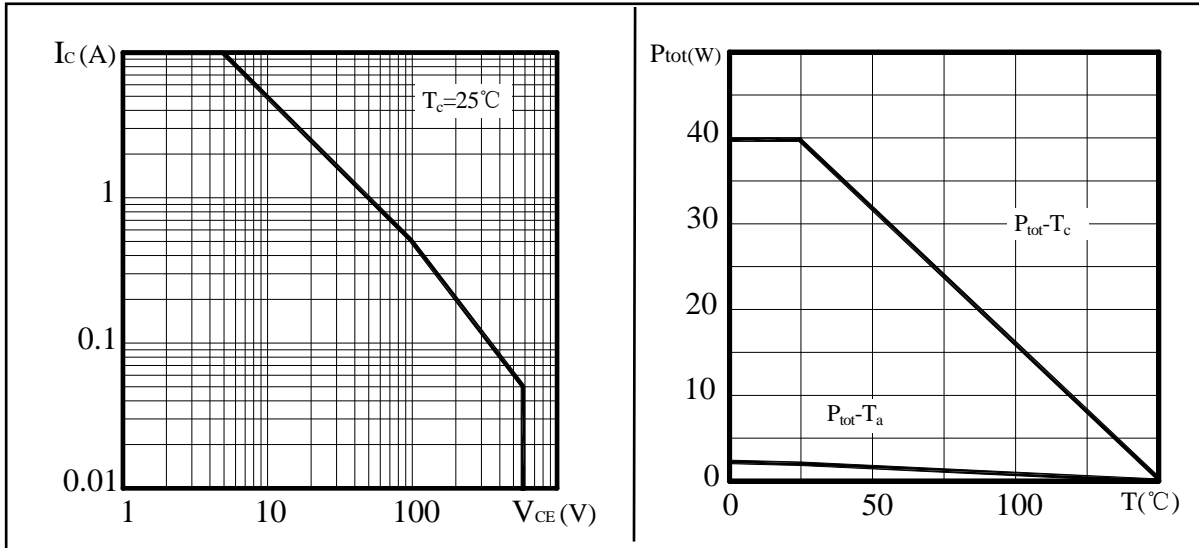


Figure 3  $I_C-V_{CE}$  Characteristics(Typical)

Figure 4  $h_{FE}-I_C$  Characteristics(Typical)

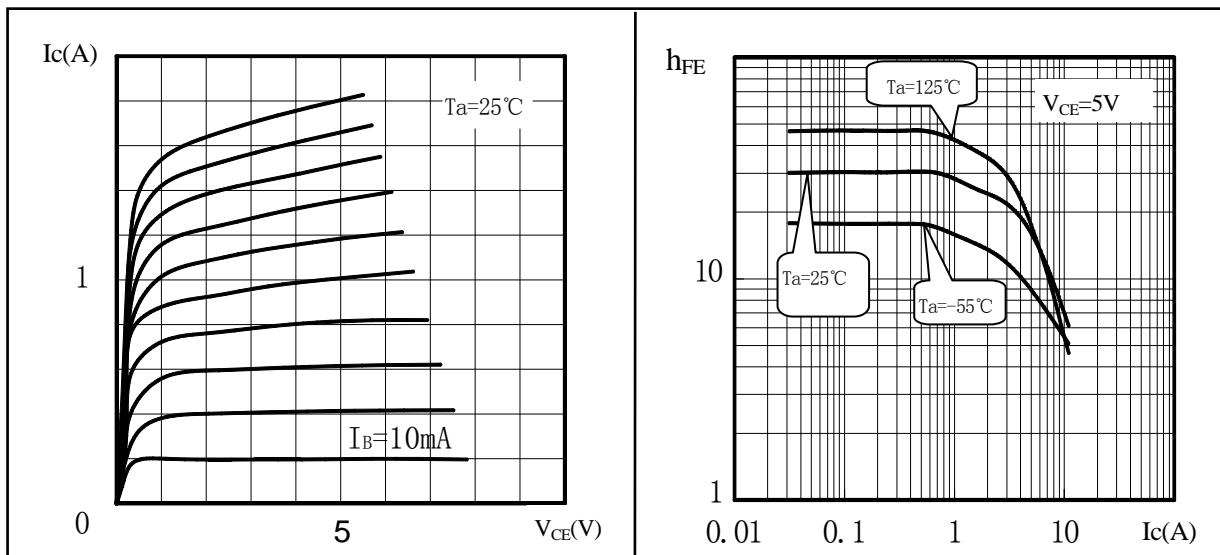
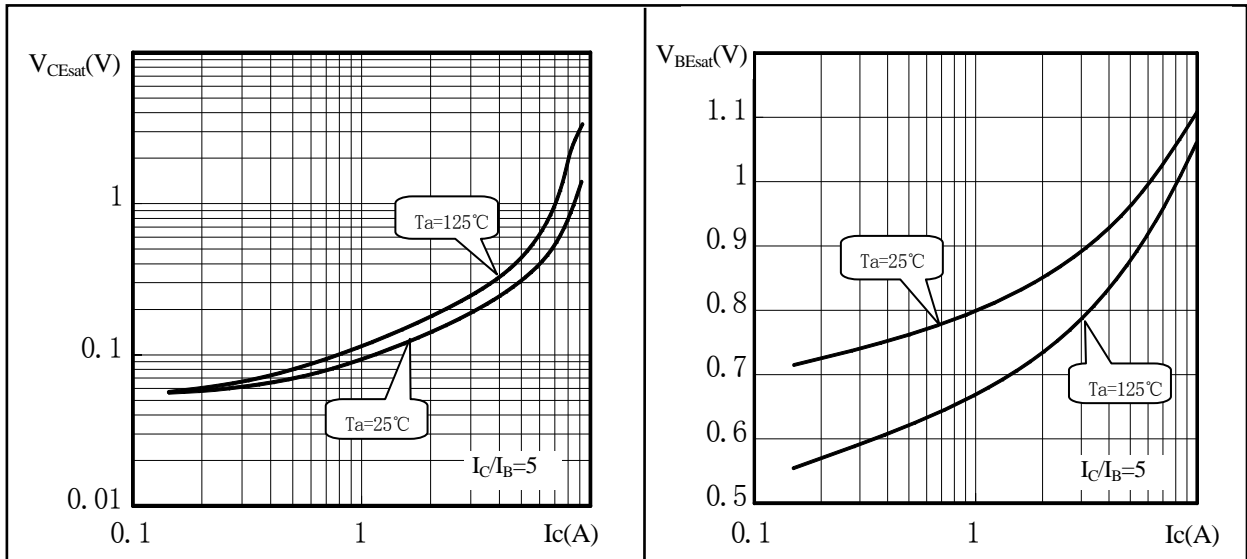
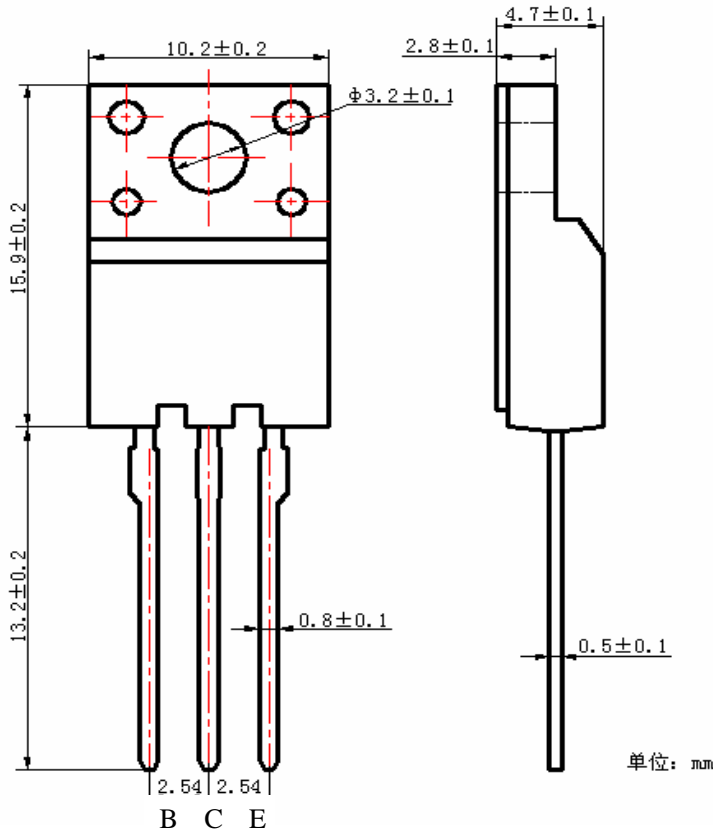


Figure 5  $V_{CE(sat)}$ - $I_C$  Characteristics(Typical)

Figure 6  $V_{BE(sat)}$ - $I_C$  Characteristics(Typical)



## 6 External Dimension (TO-220F)



## 7 Explanation

### 7-1 Packing

- 1) small packing, 50 pieces per plate
- 2) middle packing, 20 plates per middle paper box
- 3) big packing, 5 box per big paper case

### 7-2 Warnings:

- 1) All the products made from Huajing Microelectronics should be in accordance with the corresponding electrical characteristics specifications and package sizes described in the publication. Interrelated technological compact must be signed in both sides before making the special products customers demand.
- 2) Exceeding the Maximum Ratings is forbidden when the device is working. It is suggested that the device works under 80% of the Maximum Ratings. During installation please try to reduce the mechanical stress to prevent the partial distortion and transmogrification of the device case, which may result in application failure, avoid approaching to heat component, pay attention to the temperature and time in welding and adding stannum.
- 3) This publication is made by Huajing Microelectronics and subject to regular change without notice.